

January 2007

# FDS6675

SOT-23

# Single P-Channel, Logic Level, PowerTrench™ MOSFET

## **General Description**

This P-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices are well suited for notebook computer applications: load switching and power management, battery charging circuits, and DC/DC conversion.

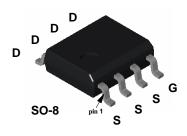
SuperSOT<sup>™</sup>-6

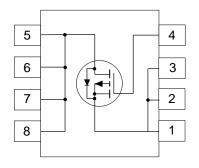
### **Features**

- -11 A, -30 V. R\_{DS(ON)} = 0.014  $\Omega$  @ V  $_{GS}$  = -10 V, R  $_{DS(ON)}$  = 0.020  $\Omega$  @ V  $_{GS}$  = -4.5 V.
- Low gate charge (30nC typical).
- $\blacksquare$  High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}.$
- High power and current handling capability.

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# **Absolute Maximum Ratings**

 $T_A = 25^{\circ}C$  unless otherwise noted

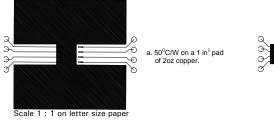
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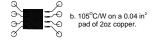
Symbol	Parameter	FDS6675	Units
/ DSS	Drain-Source Voltage	-30	V
r GSS	Gate-Source Voltage	±20	V
)	Drain Current - Continuous (Note 1a)	-11	А
	- Pulsed	-50	
$P_{D}$	Power Dissipation for Single Operation (Note 1a)	2.5	W
	(Note 1b)	1.2	
	(Note 1c)	1	
,T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150	°C
HERMA	L CHARACTERISTICS		
θJA	Thermal Resistance, Junction-to-Ambient (Note 1a)	50	°C/W
, PIC	Thermal Resistance, Junction-to-Case (Note 1)	25	°C/W

Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHAR	ACTERISTICS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25 °C		-22		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, \ V_{GS} = 0 \text{ V}$			-1	μA
		$T_J = 55^{\circ}C$			-10	μA
I <sub>GSSF</sub>	Gate - Body Leakage, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
ON CHARA	CTERISTICS (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-1	-1.7	-3	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp. Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25 °C		4.3		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_{D} = -11 \text{ A}$		0.011	0.014	Ω
		T <sub>J</sub> =125°C		0.016	0.023	
		$V_{GS} = -4.5 \text{ V}, I_{D} = -9 \text{ A}$		0.015	0.02	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V}, \ V_{DS} = -5 \text{ V}$	-50			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = -10 \text{ V}, I_{D} = -11 \text{ A}$		32		S
DYNAMIC (	CHARACTERISTICS	·		•		
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 \text{ V}, \ V_{GS} = 0 \text{ V}, $ f = 1.0 MHz		3000		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		870		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			360		pF
SWITCHING	CHARACTERISTICS (Note 2)					
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DS} = -15 \text{ V}, I_{D} = -1 \text{ A}$		12	22	ns
t,	Turn - On Rise Time	$V_{GEN}$ = -10 V, $R_{GEN}$ = 6 $\Omega$		16	27	ns
t <sub>D(off)</sub>	Turn - Off Delay Time			50	80	ns
t,	Turn - Off Fall Time			100	140	ns
$\overline{Q_{g}}$	Total Gate Charge	$V_{DS} = -15 \text{ V}, I_{D} = -11 \text{ A},$		30	42	nC
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> = -5 V		9		nC
$Q_{gd}$	Gate-Drain Charge			11		nC
DRAIN-SOL	JRCE DIODE CHARACTERISTICS AND MAXIM	UM RATINGS				
I <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current				-2.1	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -2.1 \text{ A} \text{ (Note 2)}$		-0.72	-1.2	V

#### Notes:

<sup>1.</sup>  $R_{\text{BA}}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\text{BJC}}$  is guaranteed by design while  $R_{\text{BCA}}$  is determined by the user's board design.

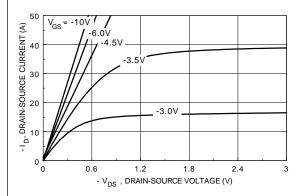






2. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2.0%.

# **Typical Electrical Characteristics**



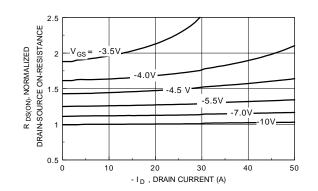
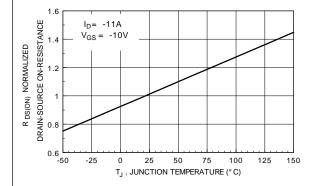


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Dain Current and Gate Voltage.



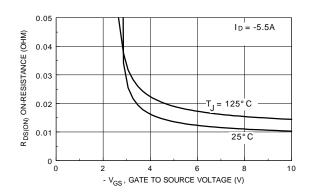
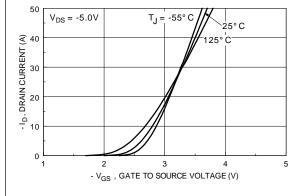


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



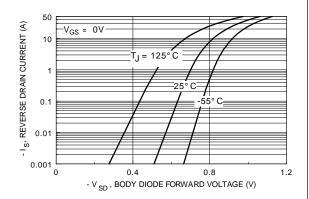
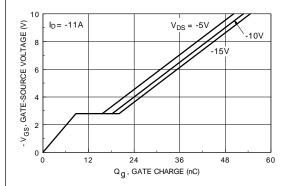


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# Typical Electrical Characteristics (continued)



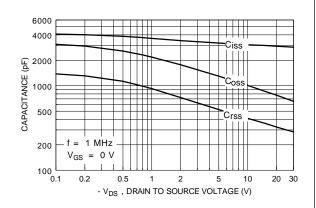
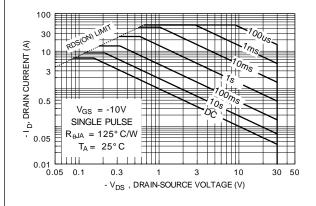


Figure 7. Gate Charge Characteristics.





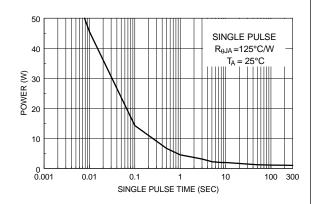


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

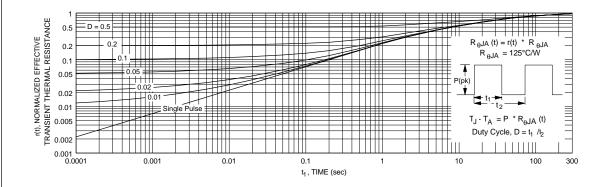


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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Rev. I22